

Notice of References Cited	Application/Control No. 10/533,888		Applicant(s)/Patent Under Reexamination KAWASE ET AL.	
	Examiner Binh X. Tran		Art Unit 1792	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,705,089	01-1998	Sugihara et al.	252/79.1
*	B	US-2004/0029395	02-2004	Zhang et al.	438/748
*	C	US-2002/0194789	12-2002	Oshima, Yoshiaki	51/308
*	D	US-2002/0077259	06-2002	Skee, David C.	510/175
*	E	US-2002/0059755	05-2002	Kido et al.	51/309
*	F	US-2003/0082998	05-2003	Carter et al.	451/41
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.